Self-assembled thin films from lamellar metal disulfides and organic polymers

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The intercalation/exfoliation reactions of MoS_2 and SnS_2 yield lamellar colloids, which may be grown layer-by-layer on cationic surfaces by alternate adsorption of cationic clusters or polymers.

Over the past several years, self-assembly has become increasingly useful as a simple and inexpensive method for making functional thin films.¹ While much of this work has focused on organic monolayers, inorganic surface heterostructures are also interesting because of the structural,² magnetic,³ electrochemical⁴ and other properties associated with inorganic compounds. Unfortunately, to date, the building blocks of these thin films have been electronic insulators: clays, metal phosphates and lamellar oxides.⁵ Here, we report the successful extension of this technique to lamellar chalcogenides, which in bulk form are semiconductors, semimetals, and metals. These materials have been used previously to prepare interesting bulk nanocomposites.⁶

Lamellar metal disulfides (MoS₂, SnS₂) were reductively intercalated by reaction with excess BuⁿLi in hexane, then added to water to make exfoliated suspensions that were approximatley 5 mass% MS₂.⁷ As prepared, these suspensions were basic, but upon dilution to 1 mass%, the pH decreased to 8–9. Attempts to lower the pH further resulted in flocculation. These 1% suspensions were stable for periods of days (orangebrown SnS₂) to weeks (brown–black MoS₂), and transmission electron microscopy (Fig. 1) revealed intact single- and multiple-sheet aggregates ranging in lateral dimensions from *ca.* 20–500 nm.

Growth of the metal disulfide films was initiated by first priming polished silicon wafers with a cationic monolayer. This was accomplished by hydroxylating the surface, by 30 min sonication in 'piranha' solution (4:1 conc. H₂SO₄–30% H₂O₂), and then adsorbing a monolayer of aluminium Keggin ions [Al₁₃O₄(OH)₂₄(H₂O)₁₂⁷⁺], (5 min adsorption from an 80 °C solution of the chloride salt⁸), or poly(allylamine hydrochloride), PAH (15 min adsorption from a 0.01 M aqueous solution at pH 8 and ambient temperature). Both surface priming procedures create a high charge density surface, which





Fig. 1 Transmission electron micrographs of (left) colloidal MoS_2 and (right) SnS_2 particles

binds the anionic MS₂ sheets. The first monolayer of MS₂ sheets was adsorbed by immersing the primed silicon into the appropriate colloidal suspension for 15 min, and rinsing with water. These MS₂ monolayers tile the surface incompletely, as shown in tapping-mode atomic force microscopy (AFM) images, Fig. 2. The adsorption process appears to select relatively small sheets from the broad distribution of sizes present in the colloid (Fig. 1). Surface coverage was estimated at about 75% for MoS₂ on the Al-Keggin-primed surface, and about 50% on the PAH-primed surface. While it was not possible to resolve the lattice structure of the MS₂ sheets, AFM line scans over the terraces of sheets showed mean roughness of the order of 1-2 Å, consistent with exposure of the basal planes. The step height from the primed substrate to the top of the sheets was typically 13-15 Å, which corresponds roughly to the thickness of a single layer of MoS₂ sheets (6 Å) plus a layer of hydrated Li+ cations.

Multilayer films were grown by sequentially adsorbing the MS₂ colloids and polymeric PAH cations in 15 min cycles, with intermediate washing steps. The layer growth was monitored by ellipsometry, transmission UV-VIS spectroscopy (using quartz substrates), and AFM. The observed change in average layer thickness per adsorption cycle, Fig. 3, was consistently 14.8(3) Å per layer pair for MoS₂/PAH and 23.8(3) Å for SnS₂/PAH. UV-VIS spectra confirmed the regular stepwise growth of film thickness. In the case of MoS₂, the layer pair thickness is approximately that expected for a monolayer of PAH plus a single sheet of MoS₂, whereas for SnS₂ it is apparent that more than one monolayer is deposited in each adsorption cycle. Consistent with this observation, TEM studies of the SnS₂ colloid show that it is not completely exfoliated. For both MoS₂ and SnS₂, the layer pair thickness was quite insensitive to the adsorption time, up to several hours. This observation is consistent with the model of electrostatic self-assembly as a self-limiting process in which film growth ceases once the layer charge is inverted by adsorption of poly-anions or -cations.

In contrast to the more regularly tiled surfaces observed with zirconium phosphate/polymer multilayers,10 AFM images of the MoS₂ multilayer films reveal a 'spongy' morphology, in which sheets and polymer appear randomly oriented. The rms roughness of a four layer pair film of MoS₂/PAH was 16 Å on the PAH-anchored substrate, and 8 Å on the Al-Keggin derivatized surface. This is consistent with the model proposed by Kleinfeld and Ferguson for multilayer growth on islands, which eventually coalesce into smoother films.¹¹ The more densely tiled first monolayer that grows on the Keggin-primed surface yields a smoother film after a few layers are grown. XPS analysis of Si-SiO_x-Al Keggin-(MoS₂-PAH)_n-MoS₂ (n = 0, 3; Table 1) films confirms that the sheets are intact and cover the surface relatively well after deposition of four layers. In the monolayer spectra, the surface coverage is low and the XPS spectrum is dominated by adventitious carbon and signals from the Si/SiO_x substrate. Both Mo and S are present in the film, but their ratio cannot be determined accurately because of counting errors. With multilayer films, the Si, Al and O signals from the buried substrate and primer layer are attenuated relative to Mo and S, which are present in the expected 1:2 ratio.

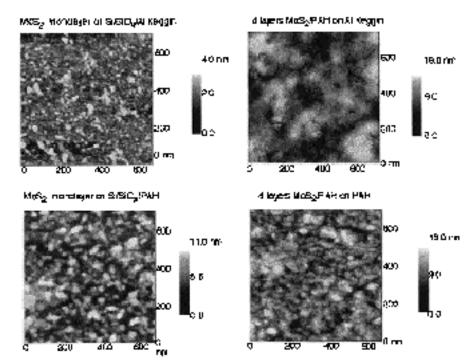


Fig. 2 Tapping-mode AFM images of monolayer MoS₂ and (MoS₂/PAH)₃MoS₂ films on Si/SiO_x/PAH and Si/SiO_x/Al Keggin substrates

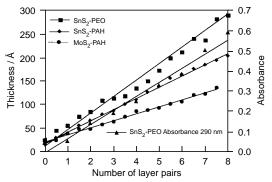


Fig. 3 Ellipsometric and UV absorbance data showing the thickness and change in absorbance of MS_2 /polymer films νs . number of layer pairs. The thickness of 'zero' layers corresponds to the SiO_x and primer (PAH or Al-Keggin). Half-integer abscissa values refer to films terminated by an MS_2 layer, and integer values by a PAH or PEO layer.

Table 1 Relative integrated peak areas, corrected for atomic sensitivity, for $Si-SiO_x$ -Al Keggin-(MoS_2 -PAH)_n- MoS_2 (n=0,3) films

	n = 0	n = 3	
Si	21.3	4.4	
Al	3.4	0.2	
Mo	0.7	1.9	
S	0.7	3.7	
C	44.0	72.9	
O	29.9	16.9	

The basal plane surface of MS₂ colloids is relatively non-polar, relative to previously studied clay, metal oxide and metal phosphate lamellar colloids. MoS₂ and SnS₂ exfoliated colloids can be re-stacked by neutral polymers, such as poly(ethylene oxide), PEO.¹² Accordingly, the cationic PAH polymer was replaced by a solution of neutral PEO, and multilayer films were grown by the same method. The film growth, monitored by ellipsometry and UV–VIS spectroscopy, is regular and the trend is similar to that found with PAH, 15 Å per layer pair with MoS₂ and 35 Å per layer pair with SnS₂. Apparently, PEO complexes the Li⁺ ions that charge-compensate the colloid sheets, much as it does in the bulk intercalation compounds.^{12b} This interaction

is sufficiently strong to persistently bind sequentially adsorbed layers.

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Notes and References

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